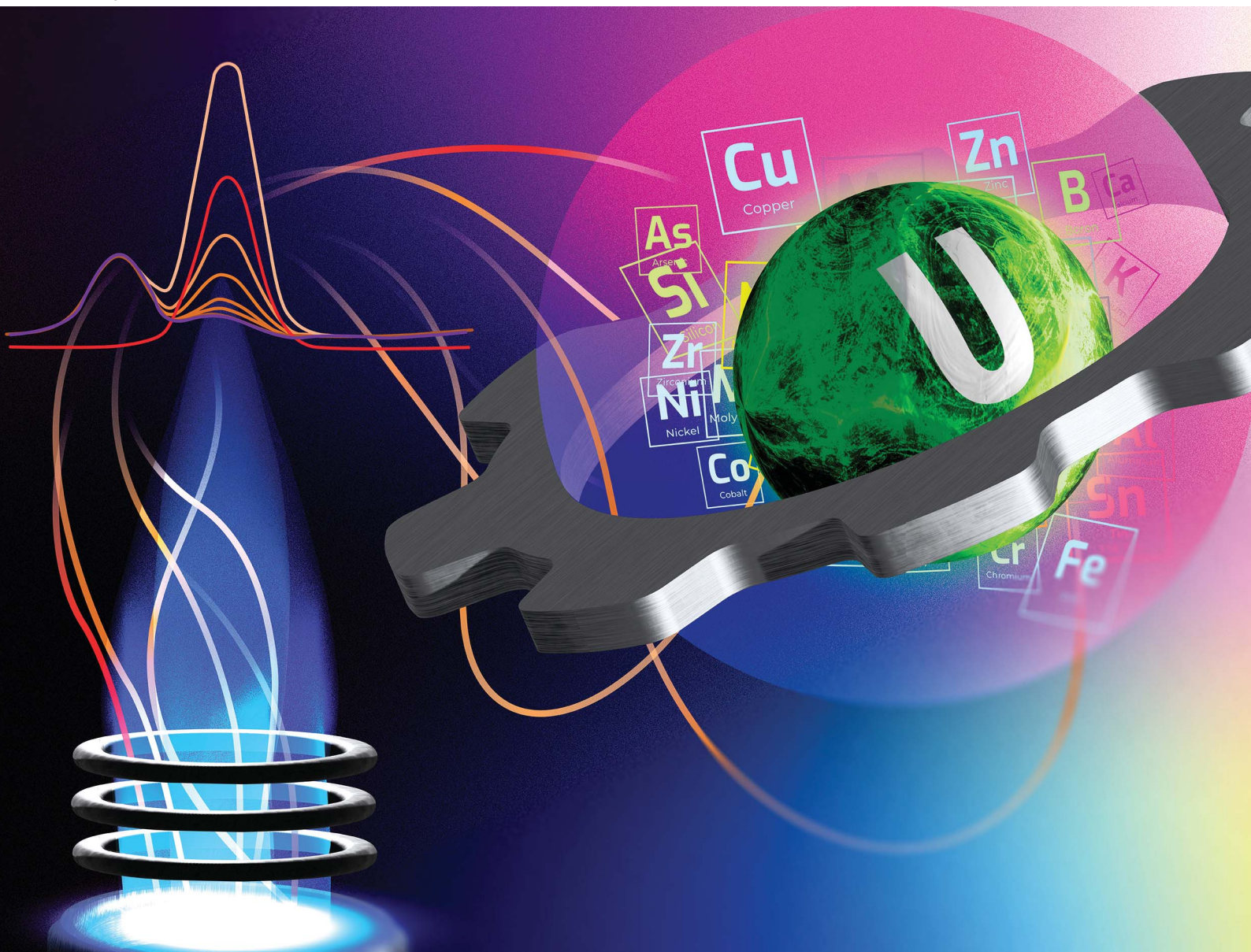


JAAS

Journal of Analytical Atomic Spectrometry

rsc.li/jaas



ISSN 0267-9477

PAPER

Luke R. Sadergaski *et al.*

Analysis of trace elements in uranium by inductively coupled plasma-optical emission spectroscopy, design of experiments, and partial least squares regression



Cite this: *J. Anal. At. Spectrom.*, 2023, 38, 800

Analysis of trace elements in uranium by inductively coupled plasma-optical emission spectroscopy, design of experiments, and partial least squares regression†

Luke R. Sadergaski, * Benjamin T. Manard  and Hunter B. Andrews 

Partial least squares regression models were optimized for the quantification of trace elements including lanthanides (e.g., Ce, Nd), transition metals (e.g., Fe, Cr, Ni, Zr), post-transition metals (e.g., Al, Pb), alkali/alkaline earth metals (e.g., Na, Mg), metalloids (e.g., Si, As) and nonmetals (e.g., P) in uranium (U) by analyzing inductively coupled plasma-optical emission spectra. Chemical separations are commonly used to separate U from trace elements to enable highly reliable measurements by removing low lying spectral interferences from U in optical emission spectra. Here, an innovative multivariate regression approach was tested to circumvent the need for separations under relevant trace concentration ranges (20–5000 $\mu\text{g per g U}$). An I-optimal design was used to efficiently select training set samples, which were validated against several quality control samples with root mean square error of the prediction values ranging from 1% to 3% for 30 elements. The methodology was validated by the analysis of reference materials CRM 124-1 and CUP-2 and compared to partial least squares regression predictions from experimental values. The exemplar results indicate that the multivariate regression approach can account for covarying and overlapping spectral features better than standard software protocols. This unique approach provides a powerful tool for measuring trace elements in U without the time and waste associated with separations or matrix matched calibration standards and may be adapted to other systems.

Received 10th January 2023
Accepted 16th March 2023

DOI: 10.1039/d3ja00013c

rsc.li/jaas

1. Introduction

Inductively coupled plasma-optical emission spectroscopy (ICP-OES) and inductively coupled plasma-mass spectrometry (ICP-MS) are well established techniques routinely used to measure trace elements in uranium (U) and other nuclear materials.¹⁻³ Measuring trace elements aids in quality control, material viability, and could provide forensic signatures.⁴⁻⁶ Trace elemental analysis by each technique is generally performed by diluting samples such that the U matrix is low, and matrix matching the calibration standards,¹ or separating the matrix completely.⁷ ICP-OES analytical data comes from the emission spectra of elements excited within a plasma with temperatures as high as 10 000 K. The ICP-OES method measures photons, rather than ICP-MS which measures ions of specific mass and is limited by emission rich f-block elements (*e.g.*, U and Pu), which could interfere with trace element spectra.

The electron-rich spectrum for U results in low-lying peaks that overlap with the emission spectra of most trace elements.

Thus, separation technologies including solvent extraction and ion exchange chromatography have been developed to minimize spectral interferences resulting from high concentrations of U relative to the trace elements.^{7–15} Recent efforts have focused on minimizing sample size, reducing method time, and automation to improve these highly effective separations.² Separations are generally assumed to be the superlative way to obtain quality ICP-OES results for each element at all trace-level concentrations. However, multivariate chemometric regression techniques could account for complex optical emission spectral signatures directly, without needing matrix matched samples.

In recent decades, advanced multivariate chemometric techniques have been developed to build high-fidelity regression models in systems with confounding, covarying, and overlapping spectral features.¹⁶ One of the most popular examples is partial least squares regression (PLSR).^{17–19} This technique has been implemented with great success in numerous fields of science and technology including food processing, pharmaceutical, and nuclear industries. PLSR is a factor analysis method that maximizes the covariance between two matrices corresponding to the spectra (X) and concentrations (Y) using combinations of latent variables (LVs). It is a supervised form of machine learning and requires a representative training set that can be efficiently selected using

Oak Ridge National Laboratory, 1 Bethel Valley Rd, Oak Ridge, TN, 37830, USA.
E-mail: sadergaskilr@ornl.gov

† Electronic supplementary information (ESI) available: Extended discussion on error propagation, statistical comparisons, multielement standard compositions, and training sets. See DOI: <https://doi.org/10.1039/d3ja00013c>

design of experiments to minimize time and resource consumption.^{20–24} PLSR could be used to model optical emission spectra and avoid the need for the U matrix removal, but such an approach has not been studied previously. This would improve the analytical time and efficiency of ICP-OES measurements.

Here, we optimize PLSR models built from optical emission spectra, determine limits of detection for numerous trace elements in a U matrix, and validate the method using quality control samples and two uranium oxide reference materials. Calibration and validation spectral data sets were selected by I-optimal designs to minimize the samples required in the training set, which spanned concentrations of U ($4\text{--}1000\text{ }\mu\text{g mL}^{-1}$) and trace elements ($0.02\text{--}2\text{ }\mu\text{g mL}^{-1}$) and covered the anticipated solution conditions ($20\text{--}5000\text{ }\mu\text{g per g U}$). These conditions are highly relevant to numerous applications in the nuclear field. Three points of scientific advancement are covered in this work: (1) multivariate analysis enabled direct quantification of trace elements and U without separations, (2) I-optimal design provided a statistical framework to minimize the number of samples in the training set without user bias, and (3) established limits of detection for numerous trace elements in U using a novel PLSR approach. Herein, we report the first-time multivariate analysis was used to model optical emission spectra and accurately measure trace elements without the need for the U matrix removal.²⁵ This new approach enables the analysis of trace elements and U simultaneously, which is expected to greatly improve the timeliness and efficiency of ICP-OES measurements in niche applications like U production, trace element determination in nuclear fuel, and intentional forensics.^{25,26} It also provides a viable option to measure elements which are difficult to chemically separate from U (e.g., Zr, Nb, and Th). This state-of-the-art approach can be extended to many applications within and beyond the nuclear field.

2. Experimental

All chemicals were commercially obtained (ACS grade) and used as received unless otherwise stated. Nitric acid 70% (HNO_3) was purchased from Sigma-Aldrich. NIST traceable U ($10\,000\text{ }\mu\text{g mL}^{-1}$) and multielement ($100\text{ }\mu\text{g mL}^{-1}$) ICP-OES standard solutions in HNO_3 were purchased from High-Purity Standards. Samples were prepared using deionized water with Milli-Q purity ($18.2\text{ M}\Omega\text{ cm}$ at $25\text{ }^\circ\text{C}$).

2.1. Sample preparation

Training set samples contained U and trace elements covering the anticipated solution conditions ($20\text{--}5000\text{ }\mu\text{g per g U}$). A list of trace elements included in the sample set are summarized in Tables S1 and S2.[†] Samples were prepared gravimetrically, using a Mettler Toledo model XS204 balance with an accuracy of $\pm 0.0001\text{ g}$. Aliquots were diluted in 4% HNO_3 or 2 M HNO_3 . Sample concentration uncertainties were determined by standard error propagation methods described in the ESI.[†] Uranium oxide (U_3O_8) certified reference materials (CRM) 124-1 (New Brunswick Laboratory Program Office, Argonne, IL, USA)

and a Canadian Uranium Product (CUP-2) U ore reference material (Ottawa, Canada) were prepared by digesting 250 mg in a Savillex vessel using 8 M HNO_3 and 0.05 M hydrogen fluoride (HF) with heat ($100\text{ }^\circ\text{C}$ overnight). The resulting solution was diluted to $1000\text{ }\mu\text{g per mL U}$ in 2 M HNO_3 before ICP-OES analysis.

2.2. Experimental design

Design of experiments was used to statistically select sample concentrations with Design-Expert (v.11.0.5.0) by Stat-Ease Inc., within the Unscrambler software package by Camo Analytics. A two-component I-optimal design was used to select training set sample concentrations using a quadratic process order and both point and coordinate exchange. The design required six model points to estimate the coefficients in the design model; these were included in the calibration set. The model points were augmented with ten lack-of-fit (LOF) points, which were used as either calibration or validation set samples. LOF points maximize the distance to other runs while satisfying the optimality criterion. The design included two numeric factors, trace element ($0.02\text{--}2\text{ }\mu\text{g mL}^{-1}$) and U ($4\text{--}1000\text{ }\mu\text{g mL}^{-1}$) concentrations, and a constraint $-0.005 \times \text{U } \mu\text{g mL}^{-1} + \text{trace } \mu\text{g mL}^{-1} \leq 0$ to ensure trace concentrations relative to U ranged from 20 to $5000\text{ }\mu\text{g per g U}$. The design was evaluated using the fraction of design space technique.²⁷ The I-optimality criterion, used to calculate I-optimal designs (also called IV or Integrated Variance), is the most desirable option when prediction performance is important.²⁸ The algorithm selects points to minimize the integral of prediction variance throughout the design space.

2.3. Inductively coupled plasma-optical emission spectroscopy

ICP-OES was used to quantify elemental concentrations in each sample. The elemental analyses were evaluated in axial view using a Thermo Fisher (Bremen, Germany) iCAP PRO instrument operated at 1150 W with an Ar flow rate of 12 L min^{-1} . The ICP-OES is equipped with a simultaneous echelle spectrometer and a high-speed charge injection device (CID) detector for the simultaneous detection of all wavelengths ($167\text{--}852\text{ nm}$). All samples were introduced with an Elemental Scientific Inc. (ESI, Omaha, NE, USA) SC-2DXi autosampler into a quartz nebulizer housed within a quartz spray chamber. All measurements were made with axial plasma viewing for enhanced sensitivity. Emission spectra were processed by adjusting the background correction and integration area using Qtegra™ Intelligent Scientific Data Solution™ software (Bremen, Germany). The interelement correction can be applied to raw data intensity values when the spectral overlap from the dominant emission lines is known. External calibration was used to determine unknown elemental concentrations using either a standard calibration curve for each element ($0.01\text{--}5\text{ }\mu\text{g mL}^{-1}$) or an I-optimal design selected training set (Section 2.2). Spectral data were postprocessed using Thermo Fisher software to help account for overlapping peaks when determining elemental concentrations by software derived intensity values. Trace metal



ICP-OES measurements in U were validated against quality control and reference samples (CMR 124-1 and CUP-2).

2.4. Partial least squares regression

PLSR is one of the most popular supervised multivariate modeling methods. It models both the X (spectra) and Y (concentration) matrices simultaneously to find the factors (also known as latent variables, LVs) in X that best predict Y , by iteratively maximizing the covariance between X and Y . The ideal number of LVs is typically selected by comparing the calibration and validation root mean square error (RMSE) vs. the number of factors in the model. Factor selection is typically performed using a set of test samples to evaluate model performance by from cross-validation or an independent set. The last factor with an appreciable decrease in the RMSE of the cross validation (RMSECV) generally corresponds to the ideal number of LVs. Including too many factors can overfit the model and introduce unwanted noise. A full cross validation, leaving one sample out at a time, was used.

The Unscrambler X software (version 10.4) was used for multivariate analysis and data preprocessing. A NIPALS algorithm with 100 iterations was used for PLSR model calibration.²⁹ PLS2 models, which handle multiple Y responses simultaneously, were used unless otherwise stated. Variable selection based on significant regression coefficients did not improve the models. Data preprocessing and feature selection methods were evaluated; however, these did not result in significant improvements (data not shown here).^{22,30,31}

2.5. Statistics and limits of detection

The RMSE was used as the primary metric for cross validation (CV) statistics and prediction (P) error, defined in eqn (1):

$$\text{RMSE} = \sqrt{\frac{\sum (y_i - \hat{y}_i)^2}{n}}, \quad (1)$$

where y_i is the known concentration, \hat{y}_i is the model predicted concentration, and n is the total number of samples.³² RMSECV and RMSEP measure the dispersion of samples around the regression line when cross validation (CV) or the validation set is used, respectively. To simplify comparisons, the RMSEP values were divided by the median of the concentration range and converted to a percentage (RMSEP%). RMSEP% values $\leq 5\%$ generally indicate acceptable model performance. The deviation (*i.e.*, uncertainty) in predicted Y -values (*i.e.*, concentrations) for each individual sample was estimated as a function of the global model error, sample leverage, and residual X -variance.³³

Percent relative difference (% RD) was used to calculate how close the predictions were to the reported mean concentration in the verification samples using eqn (2):

$$\% \text{ RD} = \frac{|C_1 - C_2|}{(C_2)} \times 100, \quad (2)$$

where C_1 and C_2 correspond to the concentration of the measured and reference values, respectively. A zeta score (ζ) was used to evaluate PLSR predictions compared to reported

reference values.⁸ Zeta scores between +1 and −1 are considered highly acceptable, whereas values greater than +2 and −2 are questionable. Zeta scores were calculated using the experimental result (x) and uncertainty $\mu^2(x)$ with the certified reference value (x_a) and its standard uncertainty $\mu^2(x_a)$ using eqn (3):

$$\zeta = \frac{x - x_a}{\sqrt{\mu^2(x) + \mu^2(x_a)}} \quad (3)$$

The International Union of Pure and Applied Chemistry defines the LOD as the lowest concentration that can be detected with reasonable certainty for a given method.³⁴ Ortiz provided an expansion of the traditional univariate LOD equation for multivariate methods to determine a pseudounivariate LOD (LOD_{pseudo}),³⁵ summarized in eqn (4):

$$\text{LOD}_{\text{pseudo}} = 3.3s_{\text{pseudo}}^{-1} \sqrt{(1 + h_{0 \text{ min}} + 1/n)\text{var}_{\text{pseudo}}}, \quad (4)$$

where s_{pseudo} is the slope of the known calibration sample concentrations plotted against the model-predicted calibration sample concentrations, $h_{0 \text{ min}}$ is the minimal calibration sample leverage, n is the number of calibration samples, and $\text{var}_{\text{pseudo}}$ is the variance of the model-predicted calibration sample concentrations. Note, these LOD_{pseudo} values are estimates and have been shown to be either consistent with or conservative when compared to more calculation-involved LOD confidence bands.³⁶

3. Results and discussion

3.1. Optical emission spectra

The optical emission spectra of most elements on the periodic table are well established. These spectra originate from atoms or ions that absorb energy from the plasma, causing electrons to move from ground to excited states. When excited electrons transition back to lower energy levels, each element emits characteristic photons of light at wavelengths corresponding to the energy change between levels. The linear relationship between the intensity of the light emitted by a given number of atoms is described by the Beer–Lambert law. Univariate regression curves are commonly used to describe how the intensity of light is related to the concentration of each element in solution. However, this calibration approach necessitates the input of spectra free from the interference of overlapping spectral features related to other elements in solution.³⁷ This linear relationship breaks down when measuring trace elements in nuclear materials with line-rich emission spectra like U.

Several emission spectra are shown in Fig. 1 to illustrate the range of U matrix spectral interference on trace element spectra. The U interference with the Fe 238.20 nm emission line resulted in a relatively simple baseline offset. On the other hand, the V 310.23 nm was more significantly influenced by convolution with the U emission peaks. The effect(s) of low-lying U peaks vary from element to element. Additionally, these effects vary significantly between emission lines from the same element (Fig. S1†). Thus, multiple emission peaks for each element must be considered.



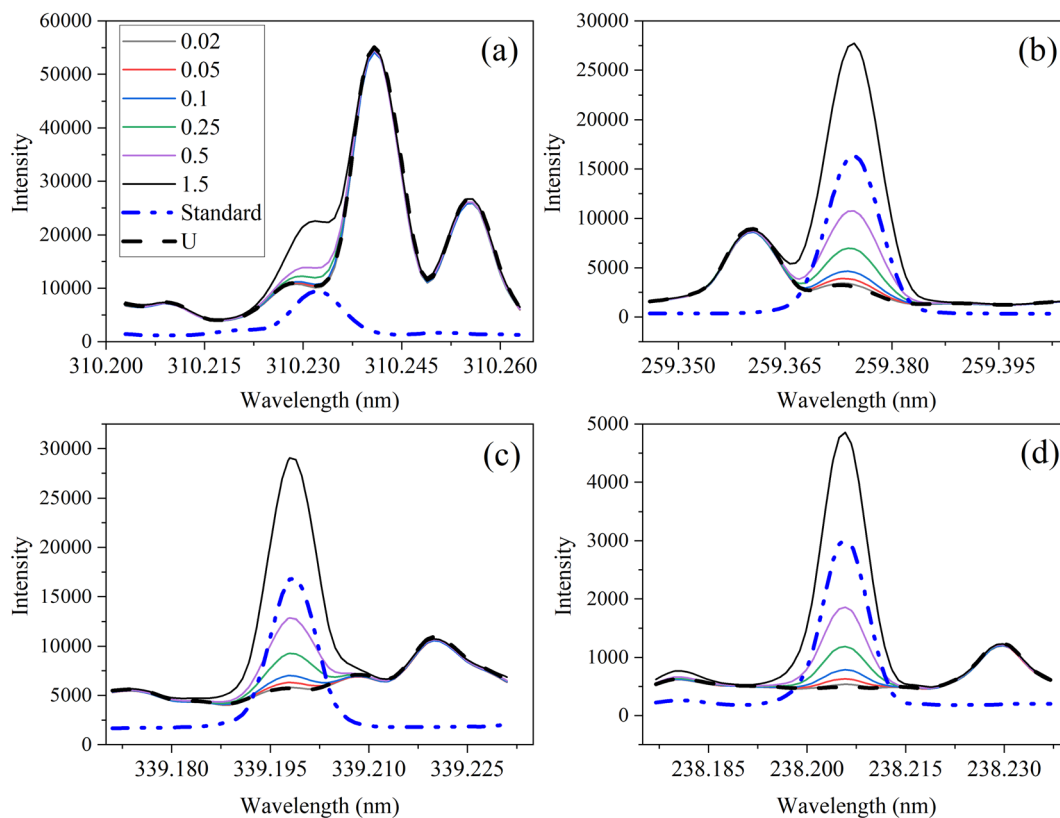


Fig. 1 Optical emission spectra of trace elements from 0.02 to 1.5 $\mu\text{g mL}^{-1}$ in 1000 $\mu\text{g per mL U}$ for (a) V 310.23 nm, (b) Mn 259.37 nm, (c) Zr 339.20 nm, and (d) Fe 238.20 nm compared to a standard (1 $\mu\text{g mL}^{-1}$ multielement standard) and a 1000 $\mu\text{g per mL U}$ sample.

Interferences from adjacent or overlapping emission lines from the matrix (U) complicated quantification of most elements using standard univariate calibration and instrument software settings. Several examples are provided in Table 1. The emission spectra were postprocessed by adjusting the background integration area using Qtegra™ Intelligent Scientific Data Solution™ software. The univariate calibration curves for each species, without the U matrix, were used to quantify trace elements in the U matrix for several quality control samples (Table S4†). The RMSE% for five trace elements when compared to reference values are shown in Table 1. The RMSE% for U concentration (emission peak 385.96 nm) by the univariate approach was 2.6%. Trace Fe was the only element quantifiable by this standard approach (*i.e.*, $\leq 5\%$). This confirms previous findings that required matrix separation of trace elements before quantification with standard ICP-OES methods.⁸

Table 1 RMSE% for five trace elements calculated by the standard univariate approach

Element (nm)	RMSE%
Mn 259.37	15.7
Nb 309.42	16.8
V 310.23	111.0
Zr 339.20	11.7
Fe 238.20	3.2

Therefore, a multivariate approach was investigated to account for overlapping U peaks and improve trace quantification by analyzing optical emission spectra directly.

3.2. Selecting sample concentrations

Supervised multivariate regression models must contain samples covering the anticipated conditions; trace concentrations from 20 to 5000 $\mu\text{g per g U}$. Optimal designs have been used with great success to minimize the number of samples in spectral training sets.^{21,22} They are the most flexible, user friendly, and efficient option for selecting training set concentrations when the fewest number of samples is desired. One-factor-at-a-time methods, more commonly used for selecting samples, result in numerous samples.²⁴ For example, a 2-factor set varied at 5 levels would require 25 samples (5^2).

Sample concentrations were selected by I-optimal experimental design. Six model points were augmented with ten LOF points (Table 2). The ratio was calculated by dividing the trace (μg) by the U (g) to obtain $\mu\text{g per g U}$. LOF samples fall within the factor space (*i.e.*, no vertex points) and can be added to the calibration set or used as a statistically derived validation set to avoid user bias. Here, the calibration set contained 12 samples, and the validation set contained 10 samples including 4 LOF points and an additional set of 6 validation samples (Table S3†) to cover the factor space for each variable. Additional LOF points could be included in future designs to provide more



Table 3 RMSEP and RMSEP% values for U and trace element and factors included in the model

Element (nm)	U		Trace		Factors
	($\mu\text{g mL}^{-1}$)	RMSEP%	($\mu\text{g mL}^{-1}$)	RMSEP%	
Mn 259.373	4.3	0.9	0.018	2.29	2
Nb 309.418	6.64	1.4	0.022	2.80	2
V 310.230	7.61	1.6	0.0085	1.08	4
Zr 339.198	9.95	2.0	0.015	1.91	3
Fe 238.204	12.67	2.6	0.012	1.53	4

The number of samples used to train the PLSR model was consistent with the traditional approach that typically requires six trace element standards and six U standards (12 total).

The RMSEP and RMSEP% values for U and trace elements are reported in Table 3. RMSEP values approximate the \pm error associated with predicted values. The number of factors varied between elements. Two or three factors was the most common, although several elements used four or even five factors. Zirconium (Zr) and niobium (Nb) emission spectra are convoluted with low-lying uranium spectra (Fig. 1 and S2†). Zirconium and niobium are difficult to separate from uranium using common methods (e.g., UTEVA).⁸ The PLSR approach measured both Nb and Zr with high accuracy without separation. This highlights a major benefit of this new approach for modeling emission spectra directly.

A different number of factors were used, despite there being two species (Y variables) in each PLSR model. This could be related to the dissimilar intensities of low-lying U peaks relative to trace element peaks. The explained variance plots were compared to X-loadings to better understand differences between models and confirm that the models were describing relevant features in the spectra. Line loadings should have

a profile like the original spectra. An example with Zr and Mn models is shown in Fig. 3. The calibration total explained Y-variance for Zr (factors-3) and Mn (factors-2) was 99.95% and 99.94%, which indicated that most of the total variation in Y (i.e., concentration matrix) was accounted for. CV explained variance plots matched the calibration, which suggests that each model can describe new data well, and there is no indication of overfitting (Fig. 3a and c).

X-Loading plots show the wavelengths that provide the most important sources of information. They show how the spectral data relates to the variation in Y. Variables with the largest loadings in the earlier components describe the greatest differences between samples. The first loading in each model represents the emission band of the trace species. This was consistent with the explained Y-variance plot, which indicated that the first factor primarily describes the variation in the trace species. This was expected because the trace element emission peak is the greatest source of signal variation for most species. However, for some elements (e.g., V), the low-lying U spectrum is more intense than the trace element (Fig. 1) and the opposite trend in explained variance was observed (data not shown here). This could explain why PLSR models for some elements like V contained greater than three factors.

Manganese X-loadings for factors 1 and 2 are shown in Fig. 3b. These correspond almost entirely to the Mn emission band (X-loading 1) and U low-lying peaks (X-loading 2). Zirconium X-loadings for factors 1, 2, and 3 are shown in Fig. 3d. The first and second loadings look like the optical emission spectra for Zr and U, respectively (Fig. 1). The X-loading for factor 2 looks primarily like the background component from the U low-lying peaks. This is consistent with the explained Y-variance plot, which shows that the second component describes mostly the U portion. The second component describes some information related to the trace species, particularly in the Zr model.

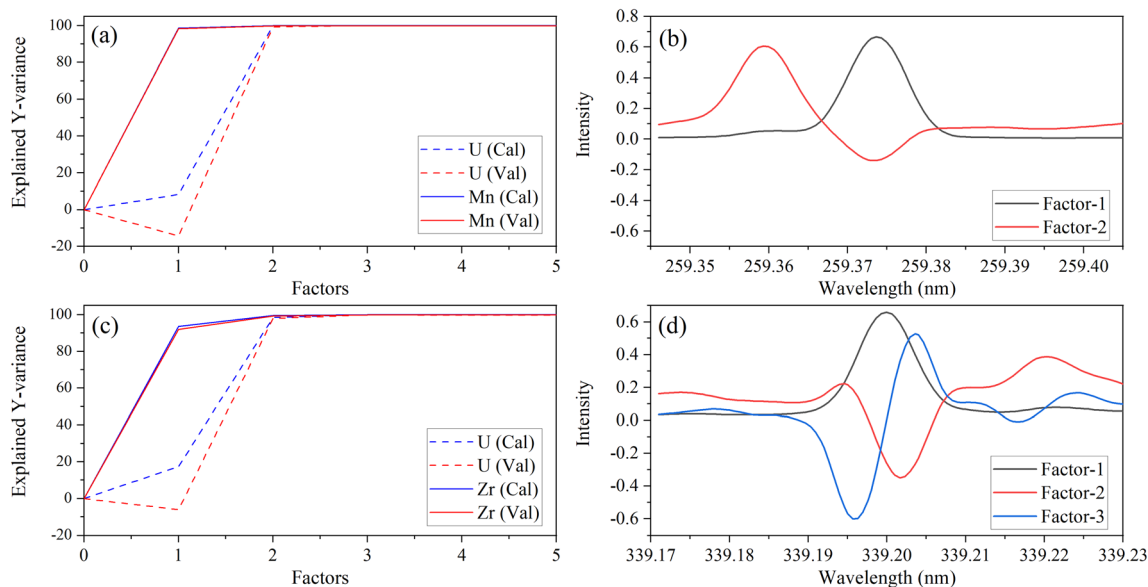
**Fig. 3** Explained variance and X-variable (nm) loadings plot for Mn 259.373 nm (a, b) and Zr 339.198 nm (c, d).

Table 4 Predicted $\mu\text{g per g U}$ compared to the reported mean values for CUP-2 (ref. 4)^a

Element (nm)	Reference mean ($\mu\text{g per g U}$)	% RSD	Predicted ($\mu\text{g per g U}$)	% RD	LOD ($\mu\text{g per g U}$)	Zeta	LVs
As 189.04	451 \pm 62	13.7	441.5 \pm 29	−2.1	51	−0.14	2
Al 396.15	3360 \pm 390	12	3097 \pm 102	−7.8	72	−0.65	2
Ba 233.53	147 \pm 11	7.5	143.4 \pm 19	−2.5	88	−0.16	2
B 249.77	73 \pm 25	34.2	73.5 \pm 11	0.68	18	0.018	3
Be 313.04 [#]	—	—	—	—	18	—	5
Ca 339.36 [#]	8300 \pm 1600	19	7070 \pm 280	−14.8	77	−0.78	5
Cr 283.56*	19.8 \pm 2.4	12.1	24.9 \pm 22	25.7	37	0.24	3
Co 228.62	—	—	—	—	31	—	4
Cu 324.75	31.6 \pm 5.7	18.0	25.3 \pm 16	−20	28	−0.37	4
Ce 535.35	53.4 \pm 4.6	8.6	56.4 \pm 22	5.7	39	0.20	3
Dy 353.17*	24.8 \pm 2	8.1	17.6 \pm 13	−28.9	38	−0.53	2
Fe 238.20[#]	4410 \pm 600	13.6	4251 \pm 150	−3.5	35	−0.25	3
K 766.49 [#]	1480 \pm 240	16	1390 \pm 36	−6.1	19	−0.37	4
La 412.32*	24.3 \pm 7.1	29.2	19.6 \pm 20	−19.4	38	−0.22	3
Mo 202.03	1042 \pm 84	8.1	1043 \pm 16	0.0	29	0.01	4
Mn 259.37	134 \pm 17	12.7	136 \pm 14	1.8	47	0.11	2
Mg 279.55[#]	3210 \pm 500	15.6	3002 \pm 73	−6.5	45	−0.41	3
Na 589.59[#]	6050 \pm 870	14.4	5915 \pm 152	−1.1	120	−0.078	2
Ni 231.60*	34.5 \pm 4.7	13.6	33.0 \pm 11	−4.5	45	−0.13	2
Nd 401.23*	26.3 \pm 2.2	8.4	22.4 \pm 18	−15.0	33	−0.22	3
P 177.50	380 \pm 110	28.9	386 \pm 22	1.50	54	0.051	2
Pb 220.35	357 \pm 35	9.8	370 \pm 67	3.53	190	0.17	2
Si 212.41	2500 \pm 800	32.0	2113 \pm 88	−16.8	220	−0.48	2
Sn 189.99*	4.72 \pm 0.51	11	—	—	210	—	2
Th 283.72	2170 \pm 240	11.1	2229 \pm 126	2.7	200	0.22	3
Ti 323.45	225 \pm 20	8.9	224 \pm 12	−0.55	22	−0.053	3
V 310.23	890 \pm 81	9.1	944 \pm 90	6.0	58	0.45	4
W 239.71*	18.4 \pm 2.9	15.8	20 \pm 30	8.7	74	0.052	3
Zr 339.20	560 \pm 61	10.9	542 \pm 12	−3.2	37	−0.29	3
Zn 202.55	45 \pm 15	33.3	37.0 \pm 10	−18.6	37	−0.44	5

^a The asterisk (*) indicates elements below estimated detections limits. The pound (#) indicates elements where the U concentration was measured by PLS1. Abbreviations: limit of detection (LOD), latent variables (LVs), percent relative standard deviation (% RSD), percent relative difference (% RD). Elements in bold were also reported for CRM 124-1 (Table 5).

The Zr X-loading for factor 3 likely describes a combination of instrument drift and adjusts for the convolution of the Zr and U emission peaks. These results illustrate that the PLSR models are describing the data well and in a way that is consistent with reality.

3.4. Analysis of certified reference materials

The ICP-OES analysis of trace elements in U materials should be accompanied by quality control measurements using certified reference materials. Well-characterized reference materials are available.^{4–6} Standards may contain as many as 66 well-characterized elemental concentrations ranging from 0.005 to 11 000 $\mu\text{g per g U}$.⁴ Here, we evaluated how well the PLSR approach predicted impurity levels within the studied concentration range (20–5000 $\mu\text{g per g U}$) in uranium oxide CRM 124-1 and CUP-2 reference materials.^{4,6} This concentration range could be expanded in future work by modifying the I-optimal design parameters. Best case scenario detection limits for ICP-OES measurements with some elements are near $\sim 5 \mu\text{g per g U}$ when separations are used.² The limit of detection (LOD) with respect to U for each trace species varied from ~ 20 to 200 μg

per g U using PLSR. If the concentration range is extended further, more samples in the training set and a stacked regression approach could effectively cover the entire range while accounting for potential nonlinearity in the emission trends.^{20,21}

The percent relative difference (% RD) for 30 elements are reported in Table 4 (CUP-2) and Table 5 (CRM-124-1). Multiple wavelengths for most elements were evaluated. The results in Tables 4 and 5 were reported for the wavelength of each element with the best performance (*i.e.*, lowest % RD). For example, one wavelength for Al (308.215 nm) and Mn (257.61 nm) missed the mark for the lowest or both concentrations while the other wavelength provided highly accurate values (Tables 4 and 5). This shows the need to evaluate each multiple wavelengths for each element to obtain the best results.

We also employed a pseudounivariate approach to calculate the method LOD based on how well the model predicts the samples in the calibration set (see Section 2.5). The LOD approximation was generally consistent with the measured reference material concentration results. For example, the LOD for Co was calculated as 38 $\mu\text{g per g U}$. We tested the model on



^a The asterisk (*) indicates elements below estimated detections limits. The pound (#) indicates elements where the U concentration was measured by PLS1. Abbreviations: limit of detection (LOD), latent variables (LVs), percent relative standard deviation (% RSD), percent relative difference (% RD). Elements in bold were also reported for CUP-2 (Table 4). The LVs reported in Table 1 were also used here.

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on spectral variations in ICP-OES spectra, without prior chemical separations. The reduction in RMSEP compared to standard software protocols shows how multivariate analysis can be used to account for convoluted spectral features. This method improves the timeliness of ICP-OES measurements that traditionally rely on chemical separations,² and this multivariate approach can be used to measure trace species that are difficult to separate from U (e.g., Zr, Nb, Th).²⁵ The analysis presented had an overall % RD < 10% for nearly 30 elements of interest compared to two certified reference materials (CMR 124-1 and CUP-2). The zeta score determination further demonstrates the effectiveness of this multivariate approach and that it is ready for the analysis of real process solutions. This methodology can likely be applied to every element with measurable optical emission spectra and can readily adapt to support applications within the nuclear field and beyond. Future work may include further optimizing detection limits and characterizing other systems, such as mixed lanthanides and actinides, and testing this approach on other ICP-OES platforms.

Author contributions

The manuscript was written using contributions of all authors. All authors have given approval to the final version of the manuscript.

Conflicts of interest

The authors declare no competing financial interest.

Acknowledgements

This work was funded by the U.S. Department of Energy, National Nuclear Security Administration, Office of Defense Nuclear Nonproliferation Research and Development. Oak Ridge National Laboratory is managed by UT-Battelle LLC for the U.S. Department of Energy under contract DE-AC05-00OR22725. This manuscript has been authored by UT-Battelle LLC under contract DE-AC05-00OR22725 with the US Department of Energy (DOE). The US government retains and the publisher, by accepting the article for publication, acknowledges that the US government retains a nonexclusive, paid-up, irrevocable, worldwide license to publish or reproduce the published form of this manuscript, or allow others to do so, for US government purposes. DOE will provide public access to these results of federally sponsored research in accordance with the DOE Public Access Plan (<https://energy.gov/downloads/doe-public-access-plan>).

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